

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/601,502	ZHAO ET AL.
<b>Examiner</b>	Art Unit	
Eric Chang	2116	

**SEARCHED**

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST USPAT/PGPUB EPO/JPO	2/14/2007	EC
EAST Inventor search	2/15/2007	EC
Consulted Examiner James Trujillo	2/15/2007	EC